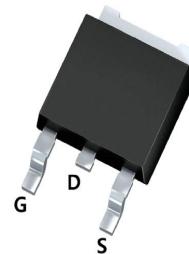




1. Features

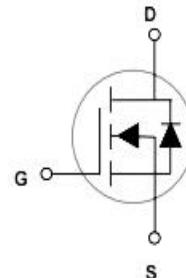
- V_{DS} 40V
- I_D (at $V_{GS}=10V$) 100A
- $R_{DS(on)}$ (at $V_{GS}=10V$) 1.9mΩ(Typ)

TO-252



2. Mechanical Data

- Case:Molded Plastic,TO-252;
- Epoxy:UL 94V-0 rate flame retardant
- Terminals:Plated Leads Solderable per MIL-STD-750,Method-2026.
- Marking: marked on body.
- Mounting Position : Any.

1.Gate
2. Drain
3. Source

3. Maximum Ratings and Electrical Characteristics

Electrical Characteristics ($T_J=25^\circ C$ unless otherwise noted)

Characteristics		Symbol	Ratings		Unit
Drain-Source Voltage		V_{DS}	40		V
Gate-Source Voltage		V_{GS}	± 20		V
Drain Current-Continuous	$T_C=25^\circ C$	I_D	100		A
	$T_C=100^\circ C$		82		
Maximum Power Dissipation		P_D	125		W
Single Pulsed Avalanche energy ⁽¹⁾		E_{AS}	400		mJ
Junction and Storage Temperature Range		T_J, T_{stg}	-55 to +150		°C
Thermal Characteristics					
Parameter		Symbol	Typ	Max	Unit
Thermal Resistance, Junction-to-Case ¹		$R_{\theta JC}$	-	1	°C/W
Thermal Resistance, Junction-to-Ambient ¹		$R_{\theta JA}$	-	50	°C/W



Characteristics	Symbol	Test conditions	Min	TYP	Max	Unit
STATIC PARAMETERS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	40	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=32V, V_{GS}=0V$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.2	1.6	2.2	V
Drain-Source On-State Resistance ²	$R_{DS(on)}$	$V_{GS}=10V, I_D=20A$	-	1.9	2.4	$m\Omega$
		$V_{GS}=4.5V, I_D=20A$	-	2.5	3.6	
DYNAMIC PARAMETERS						
Input Capacitance	C_{iss}	$V_{DS}=20V$ $V_{GS}=0V$ $f=1.0MHz$	-	3972	4650	pF
Output Capacitance	C_{oss}		-	1119	1310	
Reverse Transfer Capacitance	C_{rss}		-	82	105	
SWITCHING PARAMETERS						
Turn-on Delay Time	$t_{d(on)}$	$V_{DS}=15V, V_{GS}=10V$ $R_G=3.3\Omega; I_D=20A\Omega;$	-	18.5	23	nS
Turn-on Rise Time	t_r		-	9	12	
Turn-off Delay Time	$t_{d(off)}$		-	58.5	70	
Turn-off Fall Time	t_f		-	32	39	
Total Gate Charge	Q_g	$V_{DS}=15V, I_D=20A$ $V_{GS}=10V$	-	90	108	nC
Gate-Source Charge	Q_{gs}		-	12	15	
Gate-Drain Charge	Q_{gd}		-	18.5	24	
Diode Forward Voltage ²	V_{SD}	$I_{SD}=20A, V_{GS}=0V$	-	-	1.2	V
Gate resistance	R_g	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	-	1.0	2.5	Ω
Continuous Source Current ^{1,6}	I_s	$V_G=V_D=0V$, Force Current	-	-	100	A

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is
 $V_{DD}=25V, V_{GS}=10V, L=0.5mH, I_{AS}=40A$
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.
- 6.Package limitation current is 100A.



4.Rating And Characteristic Curves

Fig.1 Typical Output Characteristics

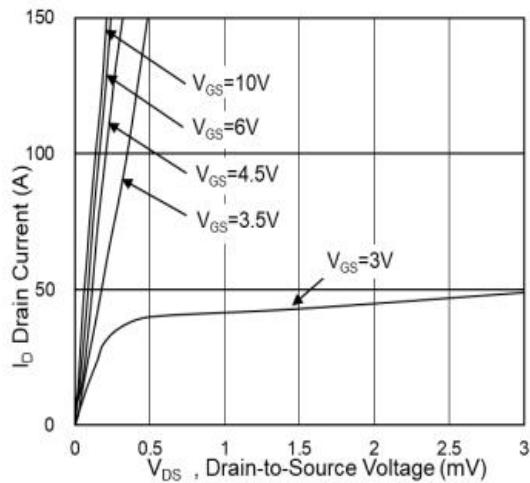


Fig.2 On-Resistance vs G-S Voltage

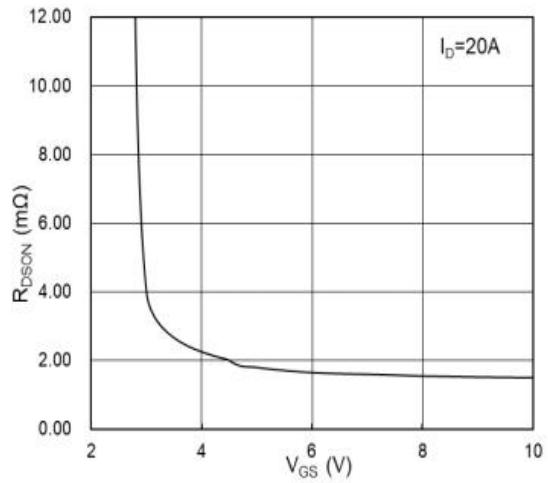


Fig.3 Source Drain Forward Characteristics

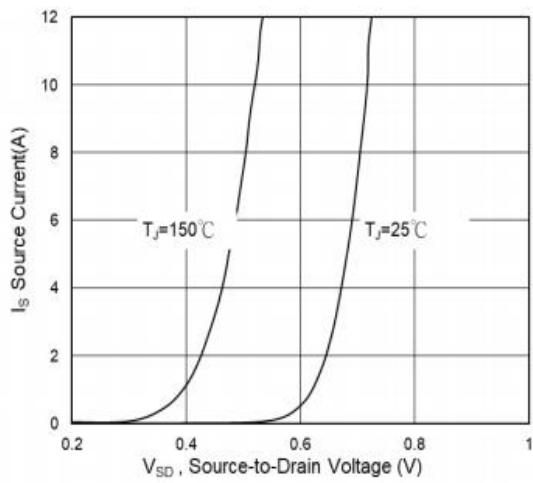


Fig.4 Gate-Charge Characteristics

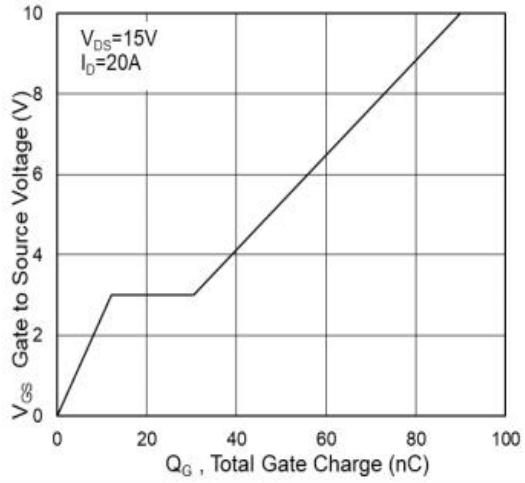
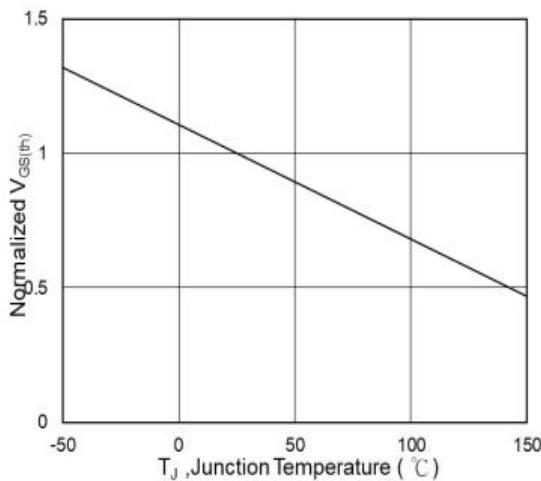
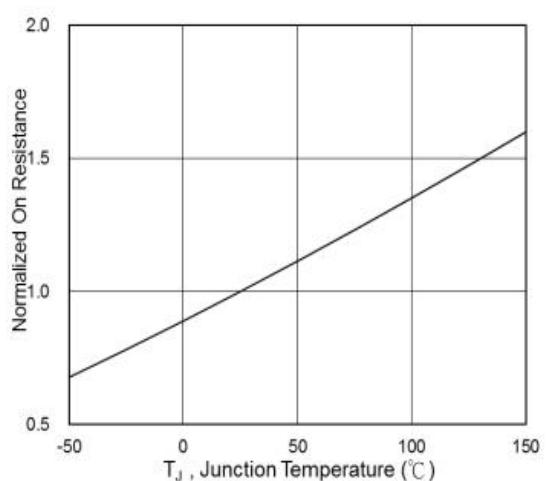
Fig. 5 Normalized $V_{GS(th)}$ vs T_J Fig.6 Normalized $R_{DS(on)}$ vs T_J 



Fig.7 Capacitance

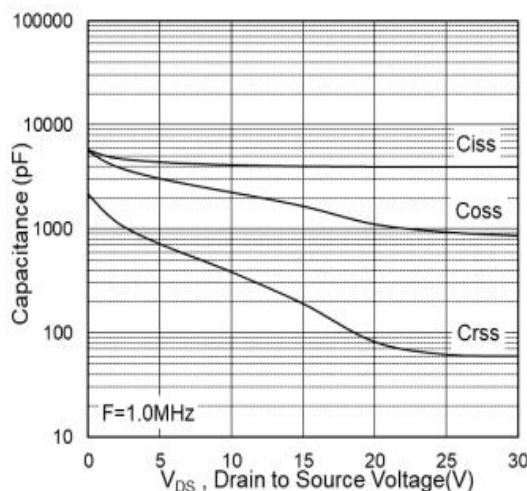


Fig.8 Safe Operating Area

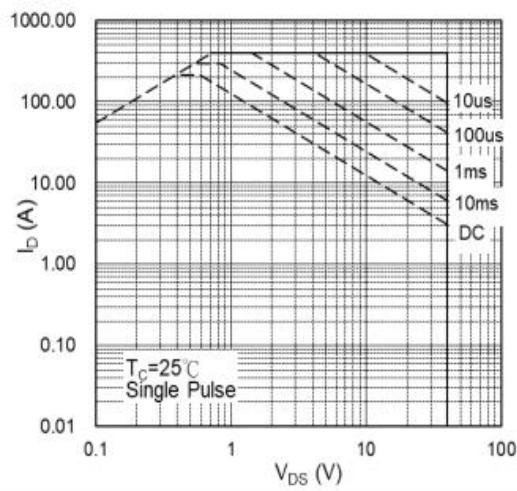


Fig 9 Capacitance

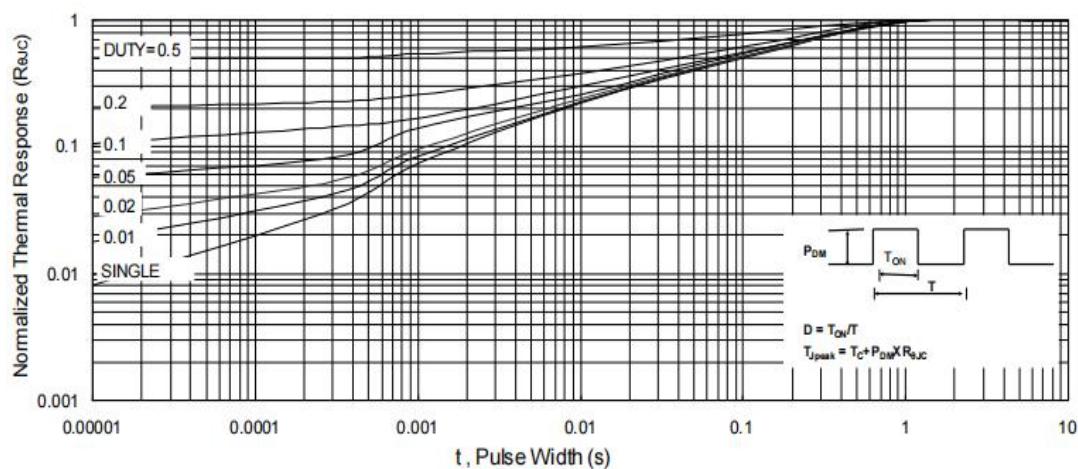


Fig.10 Switching Time Waveform

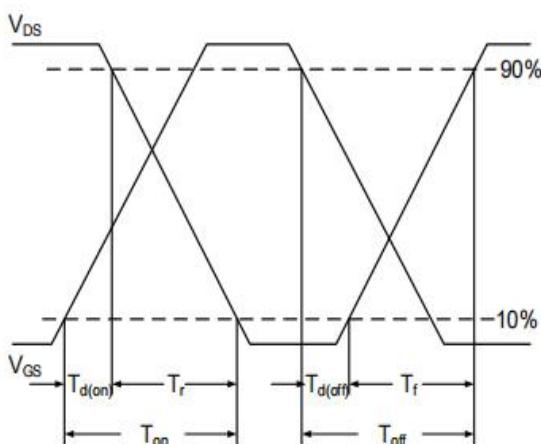
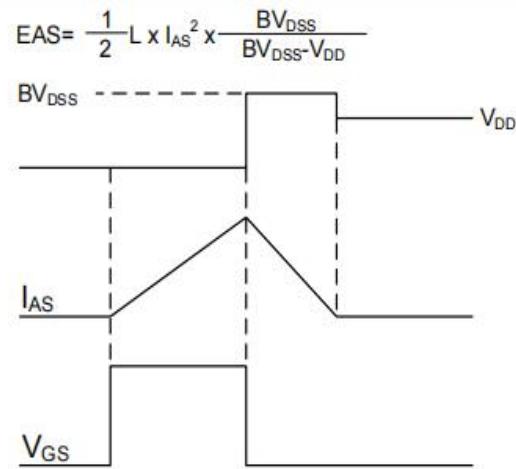
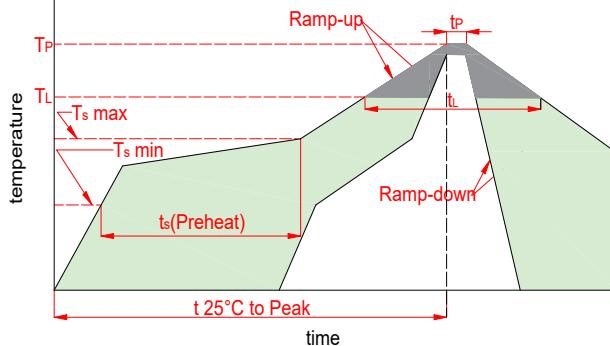


Fig.11 Unclamped Inductive Switching Waveform



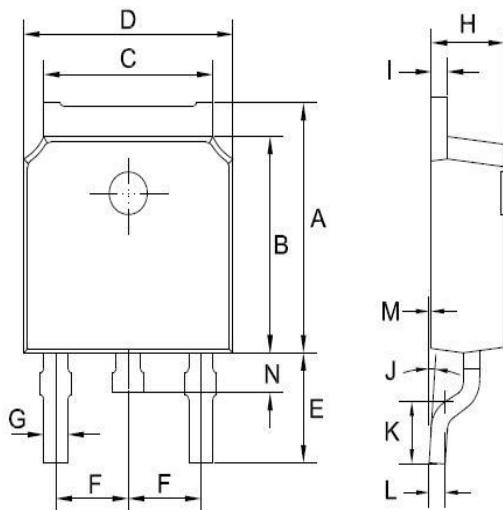


5. Soldering Parameters



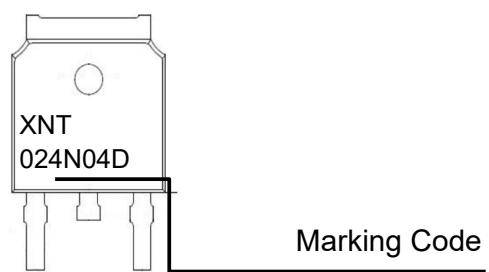
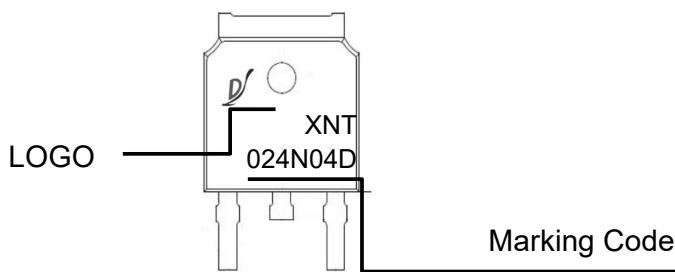
Reflow Condition		Lead-free
Pre Heat	Temp. min(T_s (min))	150°C
	Temp. max(T_s (min))	200°C
	Time(min to max)(t_s)	60~180s
Aver. ramp up rate(Liquidus Temp.)(T_L)to peak		3°C/s max
T_s (max) to T_L -Ramp-up Rate		3°C/s max
Reflow	Temp.(T_L)(Liquidus)	217°C
	Temp.(t_L)(Liquidus)	60~150s
Peak Temp.(T_p)		260 ^{+0/-5} °C
Time within actual peak Temp.(t_p)		30s max
Ramp-down Rate		6°C/s max
Time 25°C to peak Tempe.(T_p)		8 minutes max
Do not exceed		260°C

6. Dimensions



Dimensions	Inches		Millimeters	
	Min	Max	Min	Max
A	0.270	0.285	6.85	7.25
B	0.209	0.248	5.30	6.30
C	0.201	0.218	5.10	5.53
D	0.248	0.268	6.30	6.80
E	0.114	0.130	2.90	3.30
F	0.086	0.094	2.19	2.39
G	0.018	0.033	0.45	0.85
H	0.087	0.098	2.20	2.50
I	0.016	0.028	0.41	0.70
K	0.035	0.073	0.90	1.85
L	0.016	0.028	0.41	0.70
M	0.000	0.009	0.00	0.23
N	0.024	0.043	0.60	1.10

7. Test circuits



8. Package Information

Package	Quantity(pcs)
TO-252	2500



XNT024N04D

40V N-Channel MOSFET

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